

RoHS

COMPLIANT

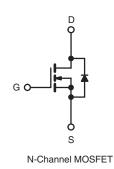
N-Channel 60 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|----------------------------|-----------------|-------|--|--|--|--|
| V _{DS} (V) | 60 | | | | | |
| R _{DS(on)} (Ω) | $V_{GS} = 10 V$ | 0.027 | | | | |
| Q _g (Max.) (nC) | 95 | | | | | |
| Q _{gs} (nC) | 27 | | | | | |
| Q _{gd} (nC) | 46 | | | | | |
| Configuration | Single | | | | | |

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





| ABSOLUTE MAXIMUM RATINGS T | _C = 25 °C, u | nless otherw | ise noted | | | |
|--|-------------------------|---|-----------------|-------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 60 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | | |
| Continuous Drain Current | V _{GS} at 10 V | $T_C = 25 \degree C$ $T_C = 100 \degree C$ | ۱ _D | 45 | | |
| | VGS at TO V | T _C = 100 °C | | 30 | А | |
| Pulsed Drain Current ^a | | | I _{DM} | 220 | | |
| Linear Derating Factor | | | | 0.32 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 100 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | PD | P _D 52 | | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 4.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to + 175 | °C | | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 129 \text{ }\mu\text{H}$, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 52 \text{ A}$, dI/dt $\leq 250 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.



| THERMAL RESISTANCE RAT | FINGS | | | | | | | |
|--|-----------------------|--|---|--------------------------------|------|--------|-------|------|
| PARAMETER | SYMBOL | TYP | • | MAX. | | UNIT | | |
| Maximum Junction-to-Ambient | R _{thJA} | - | - 65 | | | 0044 | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | - 3.1 | | | - °C/W | | |
| | | | | | | | | |
| SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, | unless otherv | vise noted | | | | | | |
| PARAMETER | SYMBOL | TES | | ONS | MIN. | TYP. | MAX. | UNIT |
| Static | | | | | | | | - |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 2 | 50 μA | 60 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, | I _D = 1 mA | - | 0.060 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ | | | 1.0 | - | 3.0 | V |
| Gate-Source Leakage | I _{GSS} | V _{GS} = ± 20 V | | | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | | V _{DS} = | $V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | - | 25 | μΑ |
| | I _{DSS} | V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C | | | - | - | 250 | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D | = 18 A ^b | - | 0.027 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} = | = 25 V, I _D = | 18 A ^b | 15 | - | - | S |
| Dynamic | | | | | | | | |
| Input Capacitance | C _{iss} | | $V_{GS} = 0 V_{,}$ | | - | 1500 | - | |
| Output Capacitance | C _{oss} | f = 1.0 MHz | | - | 720 | - | рF | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 100 | - | | |
| Drain to Sink Capacitance | С | | | - | 12 | - | | |
| Total Gate Charge | Qg | | $I_{\rm D} = 52$ A, $V_{\rm DS} = 48$ V, | | - | - | 95 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | | - | - | 27 | nC | |
| Gate-Drain Charge | Q _{gd} | | See ní | see fig. 6 and 13 ^b | - | - | 46 | |
| Turn-On Delay Time | t _{d(on)} | V _{DD} = 30 V, I _D = 52 A, R _G = 9.1 Ω, R _D = 0.54 Ω, see fig. 10 ^b | | | - | 19 | - | |
| Rise Time | tr | | | - | 120 | - | - ns | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 55 | - | | |
| Fall Time | t _f | | | - | 86 | - | | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH | |
| Internal Source Inductance | L _S | | | - | 7.5 | - | | |
| Drain-Source Body Diode Characteristic | s | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the | | - | - | 45 | A | |
| Pulsed Diode Forward Current ^a | I _{SM} | integral reverse p - n junction diode | | | - | - | | 120 |
| Body Diode Voltage | V _{SD} | T _J = 25 °C | , I _S = 30 A, | $V_{GS} = 0 V^{b}$ | - | - | 2.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | T 25 °C I | - 52 A dl/ | dt - 100 A/usb | - | 140 | 300 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | $T_J = 25 \text{ °C}, I_F = 52 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^b$ | | - | 1.2 | 2.8 | μC | |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | | |

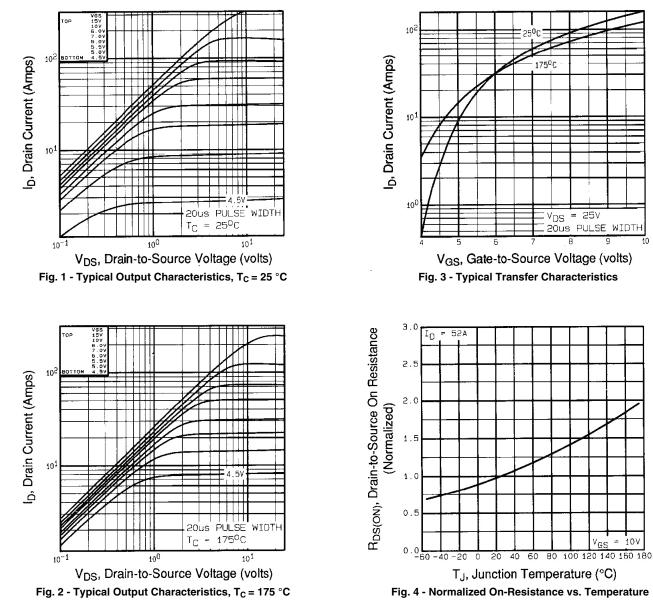
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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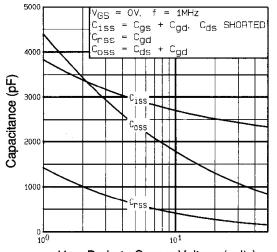
10V



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

FQPF30N06L





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

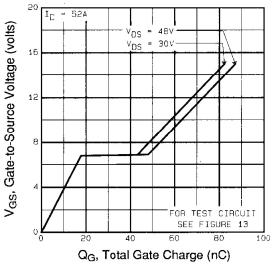


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

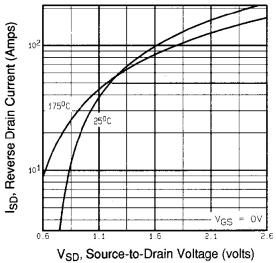
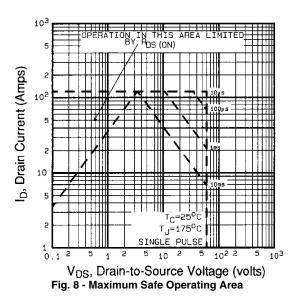


Fig. 7 - Typical Source-Drain Diode Forward Voltage



FQPF30N06L



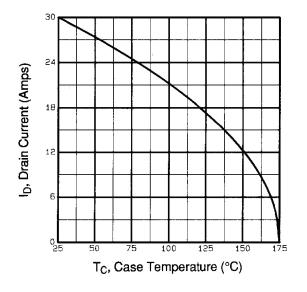


Fig. 9 - Maximum Drain Current vs. Case Temperature

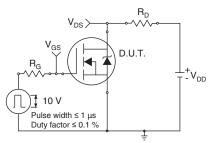


Fig. 10a - Switching Time Test Circuit

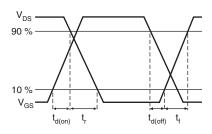


Fig. 10b - Switching Time Waveforms

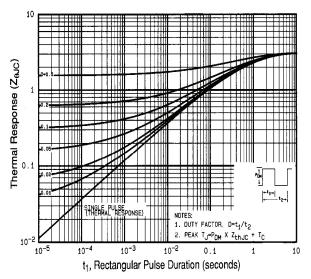
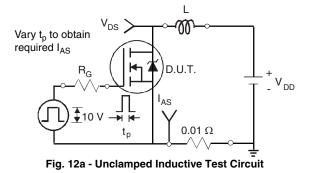


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



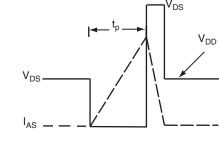
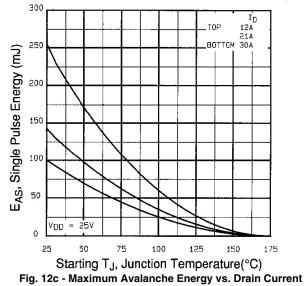
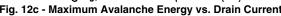


Fig. 12b - Unclamped Inductive Waveforms







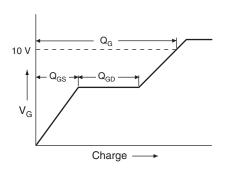
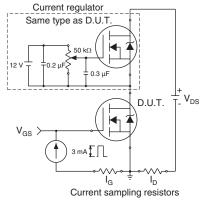
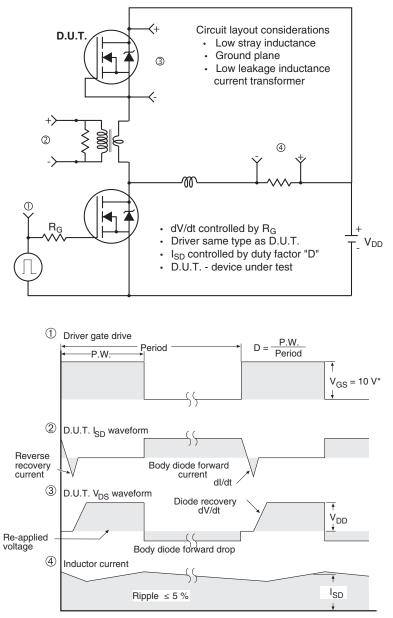


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



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